



Form PTO 1470 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250909US2		SERIAL NO. 10/811,843	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroaki KATO, et al.			
				FILING DATE March 30, 2004		GROUP 3661	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
TN	AA	5,480,219	01/02/1996	Friedrich KOST, et al.			
	AB						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
TN	AO	100 49 565 A1	05/03/2001	Germany			X
	AP	WO 02/14137 A1	02/21/2002	WIPO (with English Abstract)			X
	AQ	100 59 689 A1	06/21/2001	Germany			X
	AR	WO 90/14980	12/13/1990	WIPO			
TN	AS	40 10277 A1	10/25/1990	Germany			X
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner /Tan Q. Nguyen/					Date Considered 01/23/2007		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250909US2		SERIAL NO. 10/811,843	
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	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
TN	AO	4-342667	11/30/1992	Japan (with English abstract)			X
	AP	6-99800	4/12/1994	Japan (with English abstract)			X
	AQ	WO 02/083471 A1	10/24/2002	WIPO (with English abstract)			X
	AR	8-332933	12/17/1996	Japan (with English abstract)			X
	AS	11-152057	6/8/1999	Japan (with English abstract)			X
	AT	2001-158372	6/12/2001	Japan (with English abstract)			X
	AU	7-215193	8/15/1995	Japan (with English abstract)			X
TN	AV	8-332971	12/17/1996	Japan (with English abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Tan Q. Nguyen/					Date Considered 01/23/2007		
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SHEET 1 OF 1

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10/811,843

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hiroaki KATO, et al.

FILING DATE

March 30, 2004

GROUP

3661

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
TN	AA	5,258,912	11/02/1993	Youssef A. GHONEIM, et al.			
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	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
TN	AO	0 318 688 A1	06/07/1989	Europe	X	
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

/Tan Q. Nguyen/

Date Considered

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